

## §25. Feasibility Study on the Anion Doped Oxide - Organic Nano Composite for Energy Utilization

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The final purpose of this study is partial fluorinated tin oxide (SnO<sub>2</sub>:F) and synthesis of nanocomposite consisting of SnO<sub>2</sub>:F and carbon. As the purpose, a mechanochemical process (MCP) and a microwave irradiation one (MWR) were used. The behavior of physicochemical changed by MCP, MWR was investigated to measure by X-ray diffraction (XRD) and X-rays photoelectron spectroscopy (XPS).

The samples were used PolyVinylidene DiFluoride (PVdF), Arkema Inc. and SnO<sub>2</sub> (Aldrich, -325mesh). MCP were performed by a planetary mill (Fritsch, Pulverisette 7) with 18 balls of 10 mm diameter made from cobalt bonded tungsten carbide (WC). A mixture comprising 3 (g) SnO<sub>2</sub> and 0.3 (g) PVdF was subjected to milling at 800 (rpm) for periods up to an hour. The milling was carried out in a tightly sealed vial without evacuating or controlling the atmosphere.

The magnetic or electric fields of microwave can be separated on positions in the TE<sub>103</sub> single mode cavity with the cross-section of 54.61 mm x 109.22 mm at the frequency 2.45 GHz. The infrared pyrometer, FTZ-R220, Japan Sensor CO., LTD. measured the temperature of the sample. Heating process were carried out microwave electric field heating (E-mode), magnetic field heating (M-mode) with microwave input power (10W - 200W), and infrared heating mode (IR-mode).

Table 1 shows the sample name and sample conditions. Figure 1 shows to compar XRD profiles on the sample heated for an hour at 600 °C in vaccume and air. The peaks of SnO<sub>2</sub> lines were only obserbed in the sample (SV10-IR600A) heated in air at 600 °C. On the other hand, the mixed peaks of Sn and SnO<sub>2</sub> line in the sample heated in vacuum. In addition, the (111) rutile diffraction peaks of sample (SV00-M600V) without MCP clearly shows a shift toward higher scattering angles compaired the sample (SV10-M600V) with MCP as showing in Figure 2, implying a decrease in these interplanar distances by ca. 0.3 %.

For estimation with the he chemical states of fluorine, the samples measured by XPS, 1600-CNIS (ULVAC Inc.), under vacuum condition. The XPS spectrum is peaked at 687.8 eV and 685.2 eV in respects of Sn-F and F1s, respectively [1]. Figure 3 shows the XPS spectra with SV10, SV10-M400A and SV10-E600A. The Sn-F peaks was relatively increased with F1s peaks in SV10-M400A. And XPS intensity of SV10-E600A was decreased for dissipating the fluorine.

As a experimental results, it suggest that the MWR process was effectively for the removing the remained PvdF and increasing the Sn-F bonding under 400 °C.

Table 1 Sample name and preparative condition

Starting mixture	Sample ID	Preparative condition		
SV00 <sup>a)</sup>	SV00	As-mixed (without MW)		
	SV00-M600-A	MW-Mag	600oC, 1h	Air
	SV00-M150W-A	MW-Mag	150W, 1h (max 700oC)	Air
	SV00-M600-V	MW-Mag	600oC, 1h	Vac
SV10 <sup>b)</sup>	SV10	As-milled (without MW)		
	SV10-E600A	MW-Elec	600oC, 1h	Air
	SV10-M400A	MW-Mag	400oC, 1h	Air
	SV10-M600V	MW-Mag	600oC, 1h	Vac
	SV-IR600A	IR	600oC, 1h	Air

a) SnO<sub>2</sub>+PVdF, as-mixed  
b) SV00, co-milled for 1h

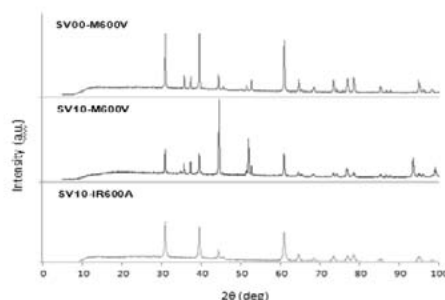


Fig. 1 XRD profiles of the sample heated for 1 hour at 600 degrees Celsius in vaccume and air

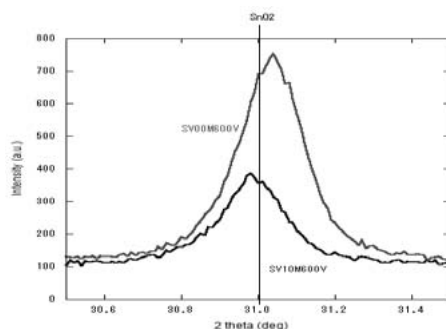


Fig. 2 (111) peaks of XRD compared the samples heated for 1 hour at 600 degrees Celsius in vaccume with and without the MCP

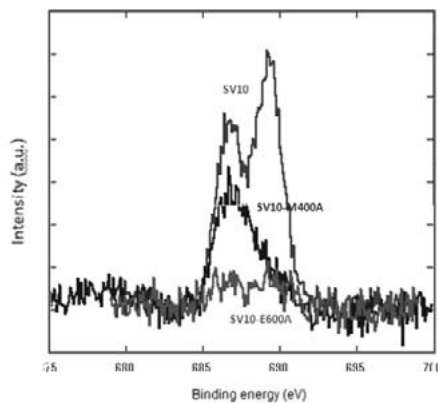


Fig.3 XPS spectra with SV10, SV10-M400A and SV10-E600A

1). M. Senna et al, Solis State Sci.30 (2014), 36-43